Application/Control No. Applicant(s)/Patent Under Reexamination 09/903,010 KATAOKA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2826 A. Sefer **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 349/155 US-2005/0259209 11-2005 Takeda et al. Α US-2003/0071952 04-2003 Yoshida et al. 349/141 В US-С US-D Ε US-US-F US-G US-Н US-1 US-J Κ US-L US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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